

Notice of References Cited	Application/Control No. 10/631,134	Applicant(s)/Patent Under Reexamination LIN, HUI-CHU	
	Examiner Eric B. Fuller	Art Unit 1762	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0165620	09-2003	Wakabayashi et al.	427/255.391
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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